Power MOSFET

–60 V, –1.1 A, 230 m Ω , Single P–Channel SOT–23 Package

Features

- Trench Technology
- NVR Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	-60	V
Gate-to-Source Voltage			V_{GS}	±20	V
Continuous Drain Cur-		T _A = 25°C	I _D	-1.1	Α
rent $R_{\theta JA}$ (Notes 1, 2, 3)	Steady	T _A = 100°C		-0.67	
Power Dissipation	State	T _A = 25°C	P_{D}	-0.47	W
R _{θJA} (Notes 1, 2)		T _A = 100°C		0.19	
Pulsed Drain Current	$T_A = 25$	°C, t _p = 10 μs	I _{DM}	25	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to +150	°C
Source Current (Body Diode)			I _S	-0.6	Α
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	268	°C/W

- 1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 3. Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

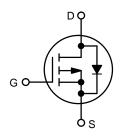


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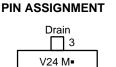
V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
-60 V	230 m Ω @ –10 V	–1.1 A
-00 V	365 m Ω @ -4.5 V	-1.1 K

P-Channel





SOT-23 CASE 318 STYLE 21



Source

MARKING DIAGRAM/

V24 = Device Code M = Date Code* ■ Pb-Free Package

(Note: Microdot may be in either location)

*Date Code orientation may vary depending upon manufacturing location.

ORDERING INFORMATION

Device	Package	Shipping [†]
NVR5124PLT1G	SOT-23 (Pb-Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

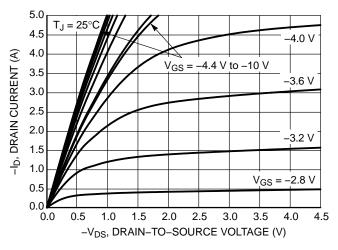
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS					•	•	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-60			V
Zero Gate Voltage Drain Current	I _{DSS}	I_{DSS} $V_{CS} = 0.V$ $T_{J} = 25^{\circ}C$				-1.0	μΑ
		$V_{GS} = 0 \text{ V},$ $V_{DS} = -60 \text{ V}$	T _J = 125°C			-10	1
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$				±100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D$	= –250 μΑ	-1.5		-2.5	V
Drain-to-Source On Resistance	R _{DS(on)}	$V_{GS} = -10 \text{ V},$	$I_D = -3 A$		183	230	mΩ
		$V_{GS} = -4.5 \text{ V},$	I _D = -3 A		280	365	1
Forward Transconductance	9FS	$V_{DS} = -15 \text{ V},$	_D = -5 A	4			S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}				240		
Output Capacitance	C _{oss}	$V_{GS} = 0 \text{ V, f} = V_{DS} = -2$	1.0 MHz, 25 V		27.6		pF
Reverse Transfer Capacitance	C _{rss}	*DS - 2			18.5		
Total Gate Charge	Q _{G(TOT)}				2.3		
Threshold Gate Charge	Q _{G(TH)}	VGS = -4.5 V. Vr	ns = -48 V.		0.5		1
Gate-to-Source Charge	Q_{GS}	$V_{GS} = -4.5 \text{ V}, V_{DS} = -48 \text{ V},$ $I_{D} = -3 \text{ A}$			0.9		nC
Gate-to-Drain Charge	Q_GD				1.0		1 ''`
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = -10 \text{ V}, V_{DS} = -48 \text{ V},$ $I_{D} = -3 \text{ A}$			4.3		1
SWITCHING CHARACTERISTICS (No	te 5)				1		
Turn-On Delay Time	t _{d(on)}				6.6		
Rise Time	t _r	Vcs = -4.5 V. Vr	sc = -48 V		10.6		ns
Turn-Off Delay Time	t _{d(off)}	$V_{GS} = -4.5 \text{ V}, V_{E}$ $I_{D} = -3 \text{ A}, R_{G}$	$= 2.5 \Omega$		12.2		
Fall Time	t _f				3.5		1 !
DRAIN-SOURCE DIODE CHARACTER	RISTICS					•	•
Forward Diode Voltage	V_{SD}	$V_{GS} = 0 V$	$T_J = 25^{\circ}C$		-0.88	-1.0	V
		$I_S = -3 \text{ A}$	T _J = 125°C		-0.76		1
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V},$ $dI_{S}/dt = 100 \text{ A/}\mu\text{s},$ $I_{S} = -3 \text{ A}$			15		ns
Charge Time	t _a				13		1
Discharge Time	t _b				2.4		1
Reverse Recovery Charge	Q _{RR}				10		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: Pulse Width $\leq 300~\mu$ s, Duty Cycle $\leq 2\%$.

5. Switching characteristics are independent of operating junction temperatures.

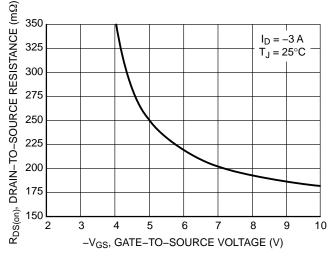
TYPICAL CHARACTERISTICS



5.0 $V_{DS} = -10 \text{ V}$ 4.5 -I_D, DRAIN CURRENT (A) 4.0 3.5 3.0 2.5 2.0 $T_J = 25^{\circ}C$ 1.5 1.0 0.5 $T_J = 125^{\circ}C$ $T_{.1} = -55^{\circ}C$ 0.0 0.0 0.5 1.0 1.5 2.0 2.5 3.0 3.5 4.5 -V_{GS}, GATE-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



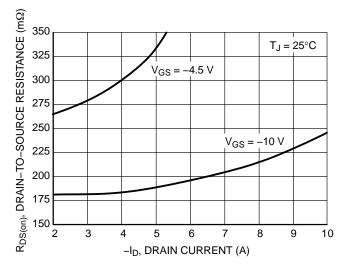
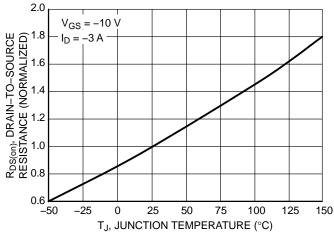


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On–Resistance vs. Drain Current and Gate Voltage



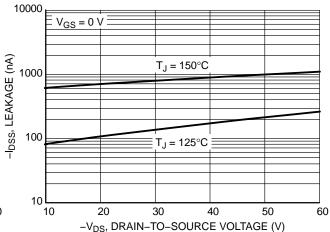


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

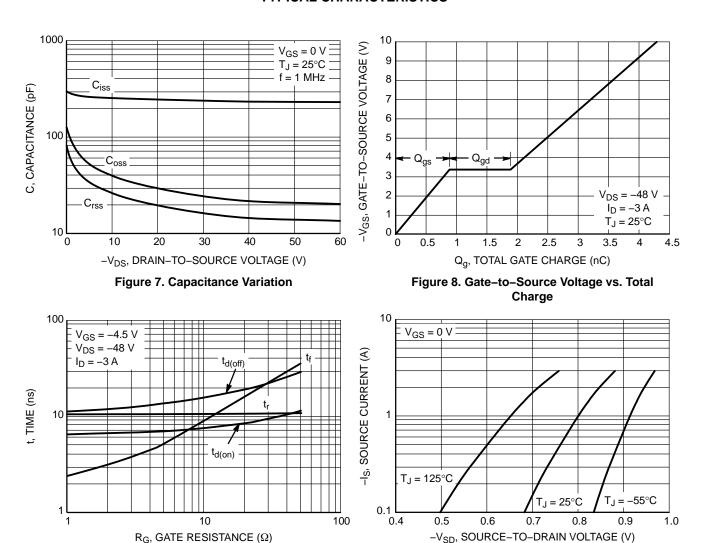


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 11. Diode Forward Voltage vs. Current

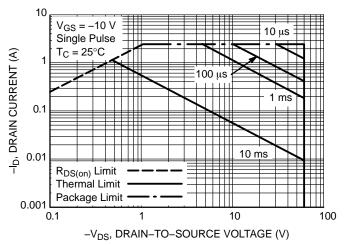


Figure 10. Maximum Rated Forward Biased Safe Operating Area

TYPICAL CHARACTERISTICS

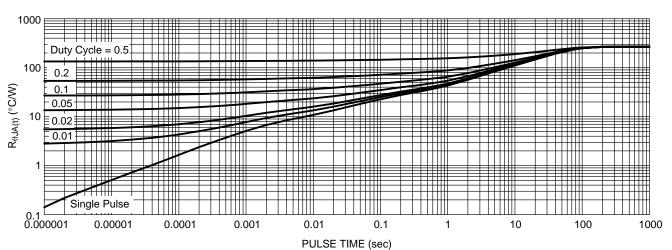
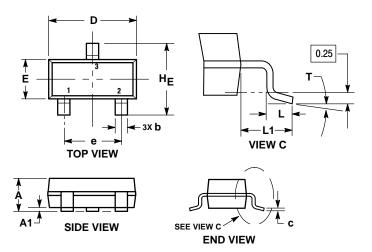


Figure 12. Thermal Response

PACKAGE DIMENSIONS

SOT-23 (TO-236) CASE 318-08 **ISSUE AR**



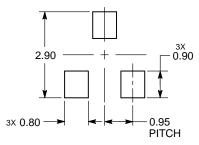
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH.
 MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF THE BASE MATERIAL.
 DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH,
- PROTRUSIONS, OR GATE BURRS

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.89	1.00	1.11	0.035	0.039	0.044	
A1	0.01	0.06	0.10	0.000	0.002	0.004	
b	0.37	0.44	0.50	0.015	0.017	0.020	
С	0.08	0.14	0.20	0.003	0.006	0.008	
D	2.80	2.90	3.04	0.110	0.114	0.120	
E	1.20	1.30	1.40	0.047	0.051	0.055	
е	1.78	1.90	2.04	0.070	0.075	0.080	
L	0.30	0.43	0.55	0.012	0.017	0.022	
L1	0.35	0.54	0.69	0.014	0.021	0.027	
HE	2.10	2.40	2.64	0.083	0.094	0.104	
Т	0°		10°	0°		10°	

STYLE 21:

PIN 1. GATE 2. SOURCE

RECOMMENDED SOLDERING FOOTPRINT*



DIMENSIONS: MILLIMETERS

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